



**SW Test Workshop**  
Semiconductor Wafer Test Workshop

# Test Cell Co-planarity Optimization



SECURE CONNECTIONS  
FOR A SMARTER WORLD

**TERADYNE**



**Presenter: Troy Harnisch**

Teradyne

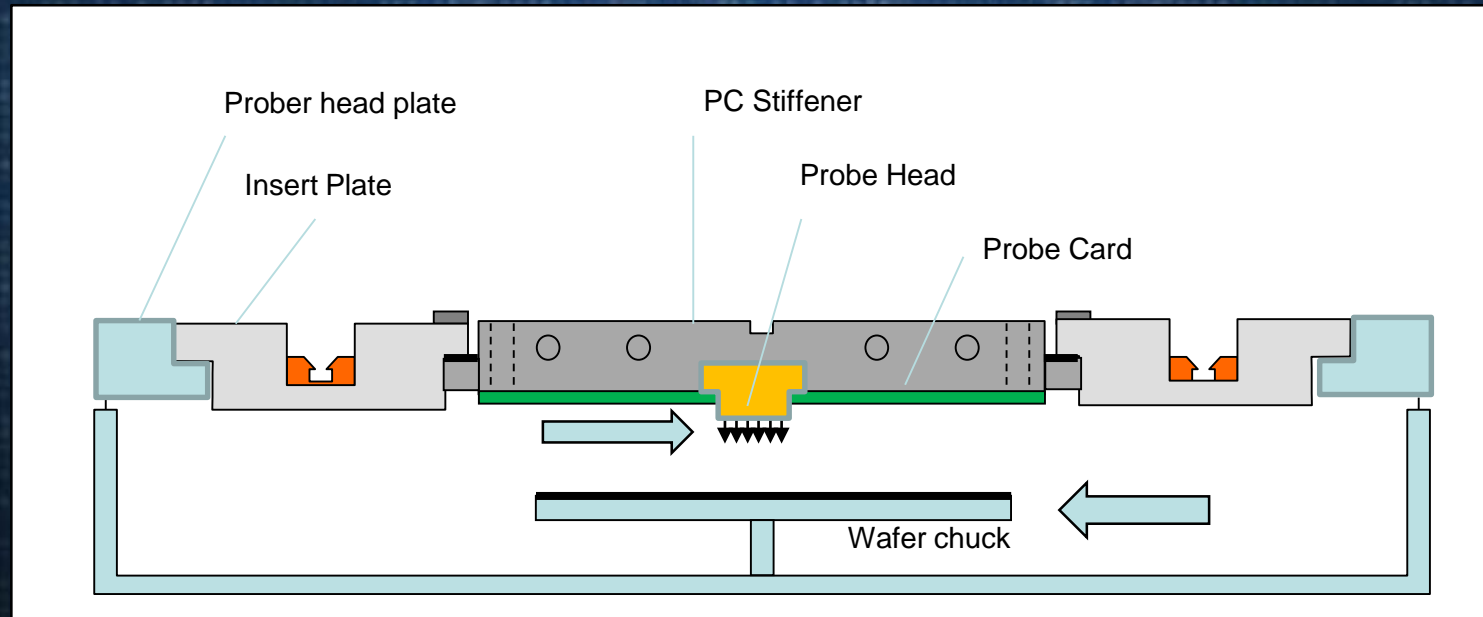
Co-authors: Doug Garrett, NXP

Hoang Nguyen, Microsemi

June 3-6, 2018

# What is co-planarity of a test cell

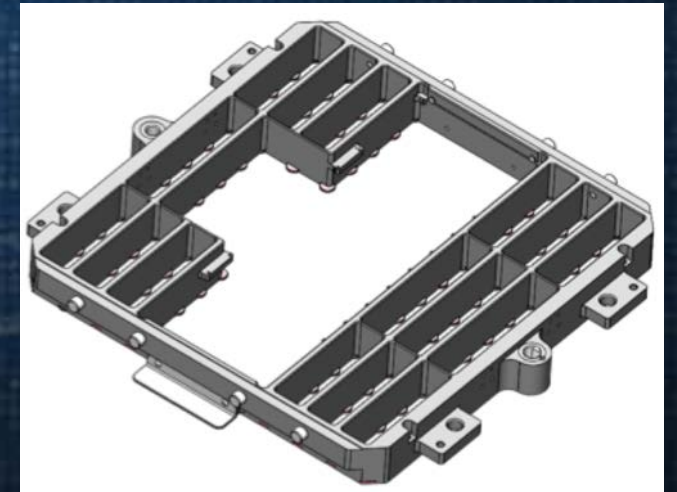
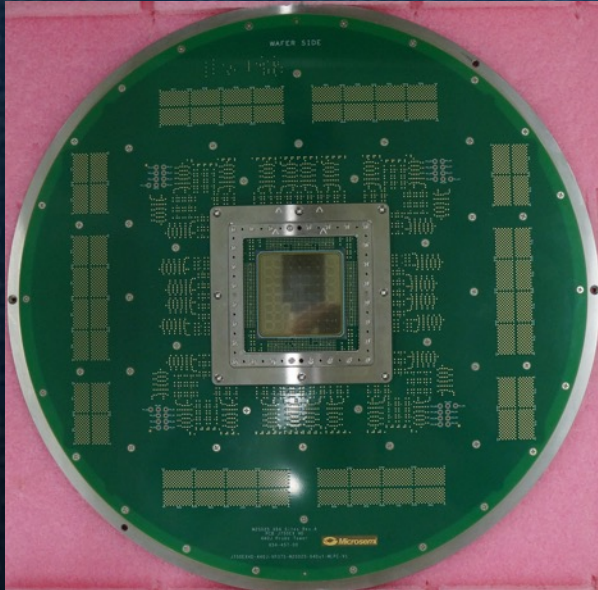
Parallel plane between wafer chuck and probe contacts





# Why is test cell co-planarity important?

- Array sizes are increasing. Some exceed the applications space.
- Probe technologies are numerous & compliance restrictions
- Pad damage from multiple probe marks (re-probing)
- Active circuitry under pad regions are sensitive to probe forces





# When is a co-planarity check recommended?

- Test cell installation / setup
- Changing instrumentation in TH
- Changing the insert plate
- Physical movement of any equipment
- Changing counter-balance weights
- Prober PM

## Optional:

- Production maintenance checks



# Goals

- Provide repeatable docking to prober interface
- Efficient conversion or transition capability
- Maintain experience with the “production proven” tools
- Closely emulate probecard architectures
- Compatible on multiple tester platforms (UltraProbe / J750-HD)
- Compatibility on probers
- Eliminate any tool calibrations
- Achieve a test cell co-planarity of <20 microns (5.5” x 5.5”)



# Precision Leveling System

- **Precision Leveling Pucks (PLP)**

- Provides repeatable docking interface – “UltraProbe only”
- Solid engagement of TH with insert plate at corners
- Utilizes the thickest area of insert plate

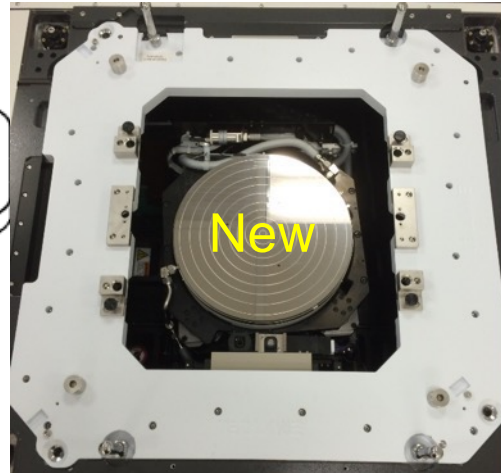
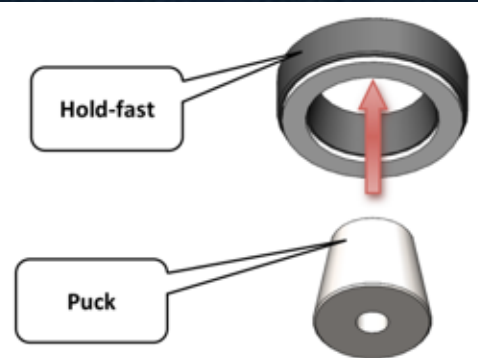
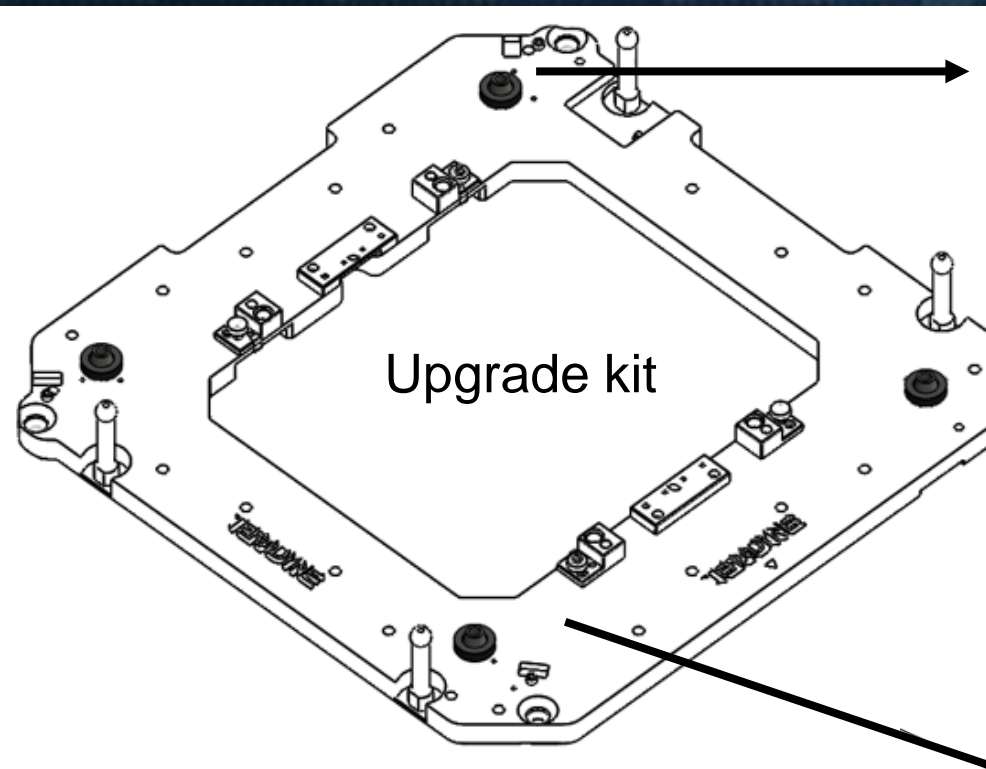
- **Fine Leveling System (FLS)**

- Provides high-precision accuracy without tool calibration
- Compatible on all UltraProbe or J750 tester and prober combinations

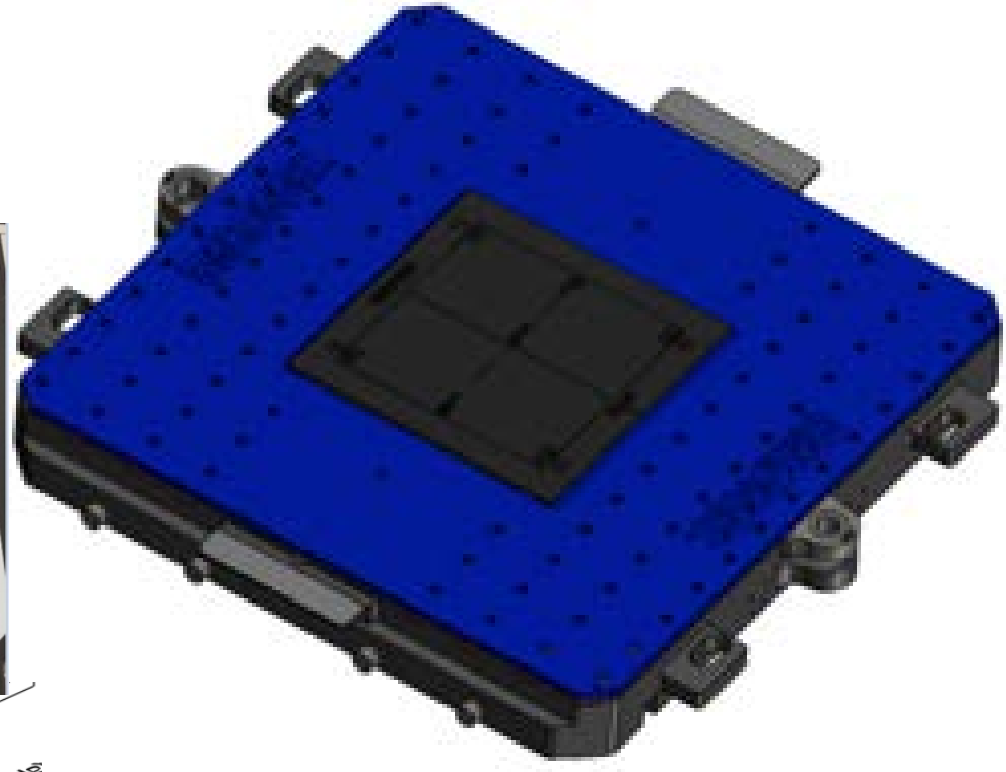
- **Software calculator tool as a guide for prober adjustments**

# UltraProbe Components

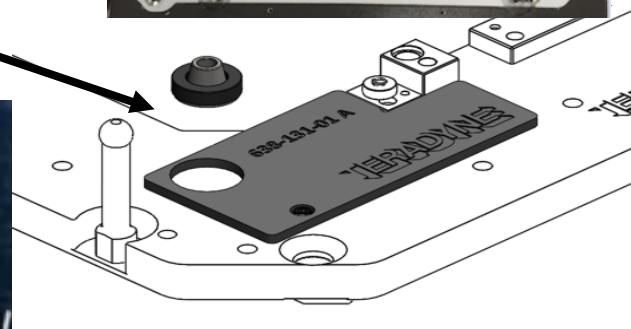
Precision Leveling Pucks



Fine Leveling System



Insert plate mounts to  
prober head stage



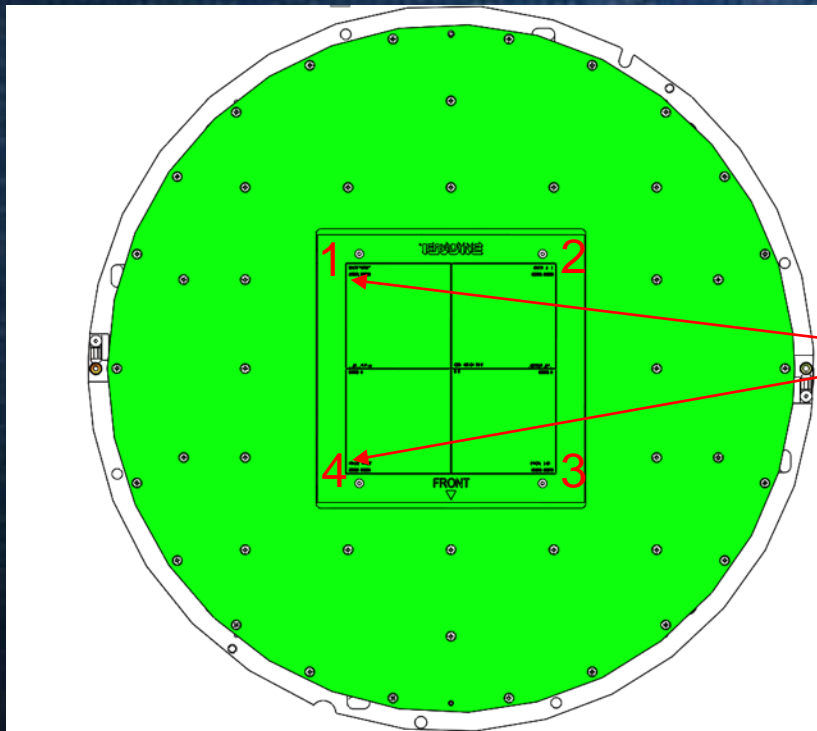
Smaller, symmetrical  
tabs w/slots



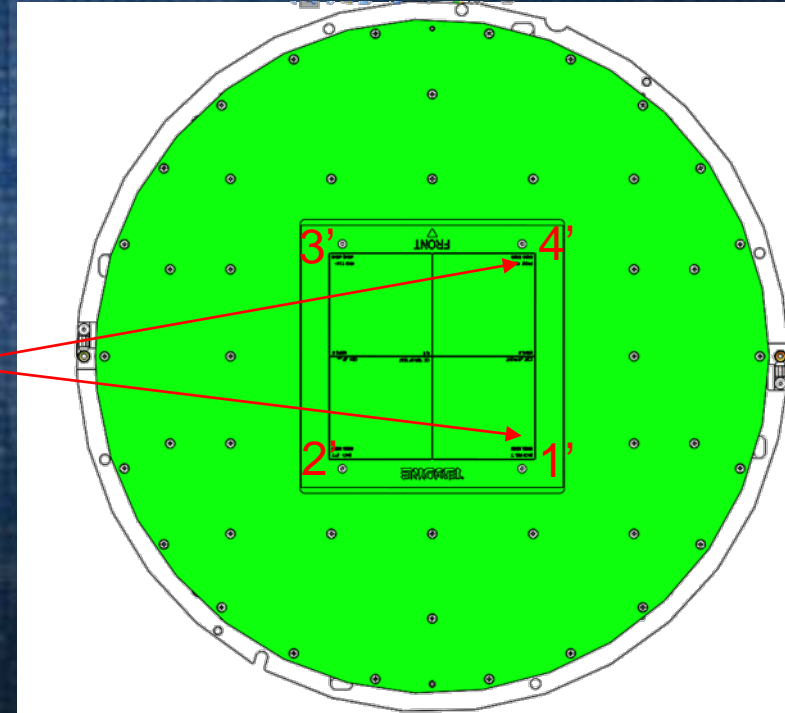
# FLS Rotation – How it works

The calibration concept is easy to understand and uses the calibrated optics of the prober. There are 4 Z-height measurement points (one in each corner) taken in the 0 degree position. These Z-values are then compared to the Z-values after rotating the tool 180 degrees. If the co-planarity is perfect, each Z-value “pair” will equal the measurement in the opposing corner. Example:  $1 = 1'$   $2 = 2'$  etc. If not equal, this provides the delta from perfect co-planarity and the height difference can be determined whether “+” or “-” from any given corner.

0° POSITION



180° ROTATION

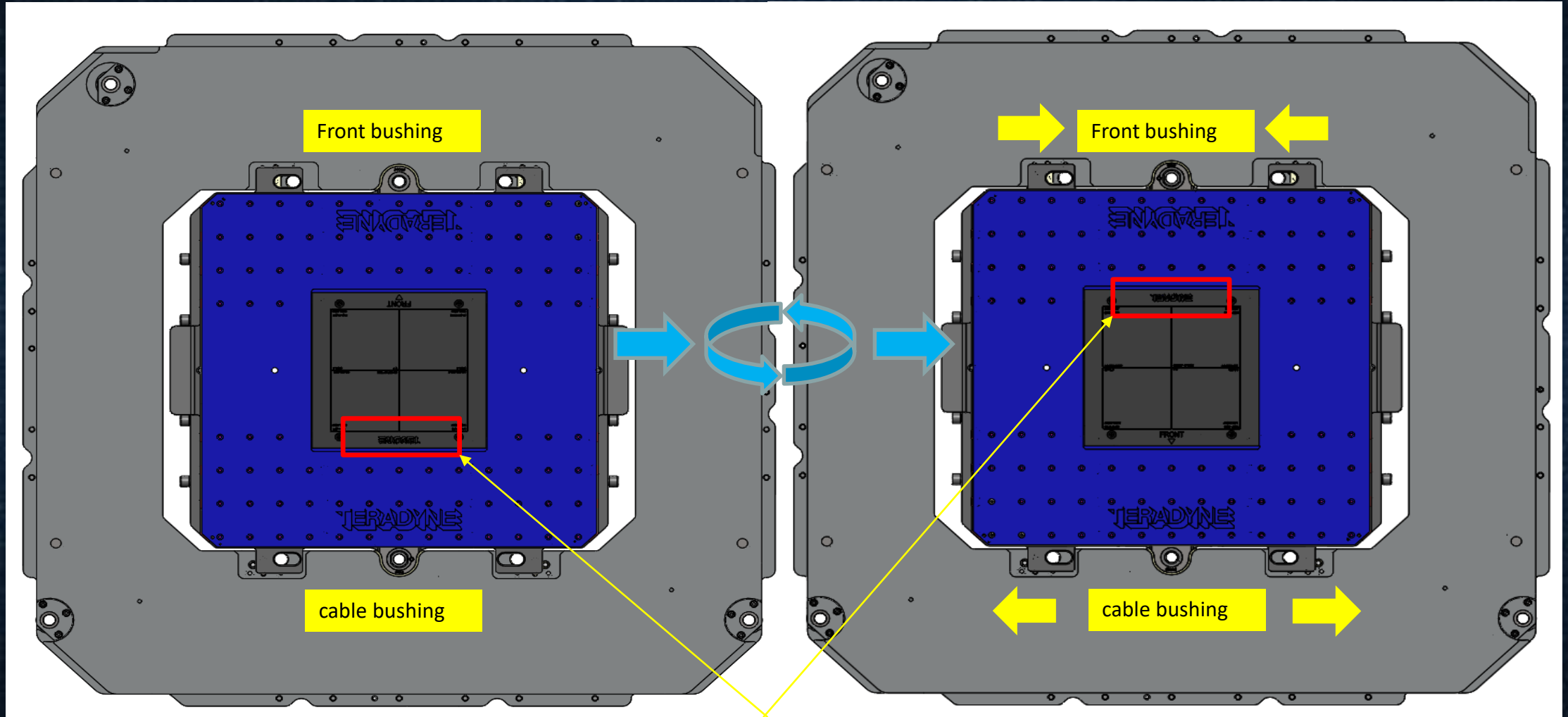




# FLS Rotation Overview

0° POSITION

180° ROTATION



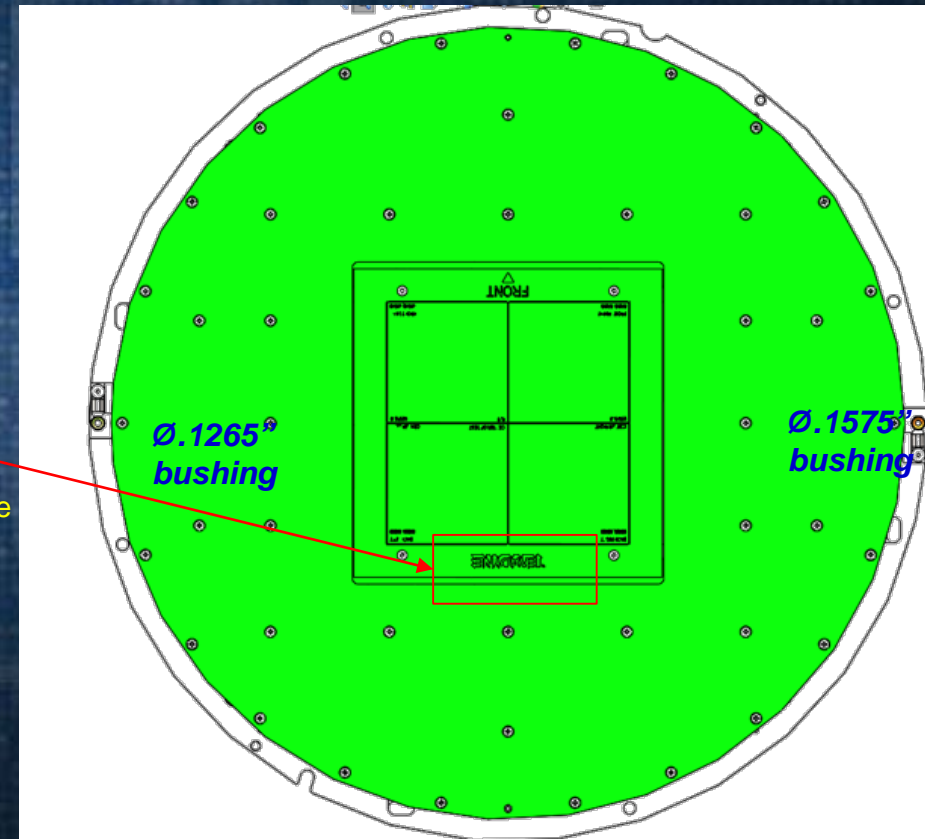
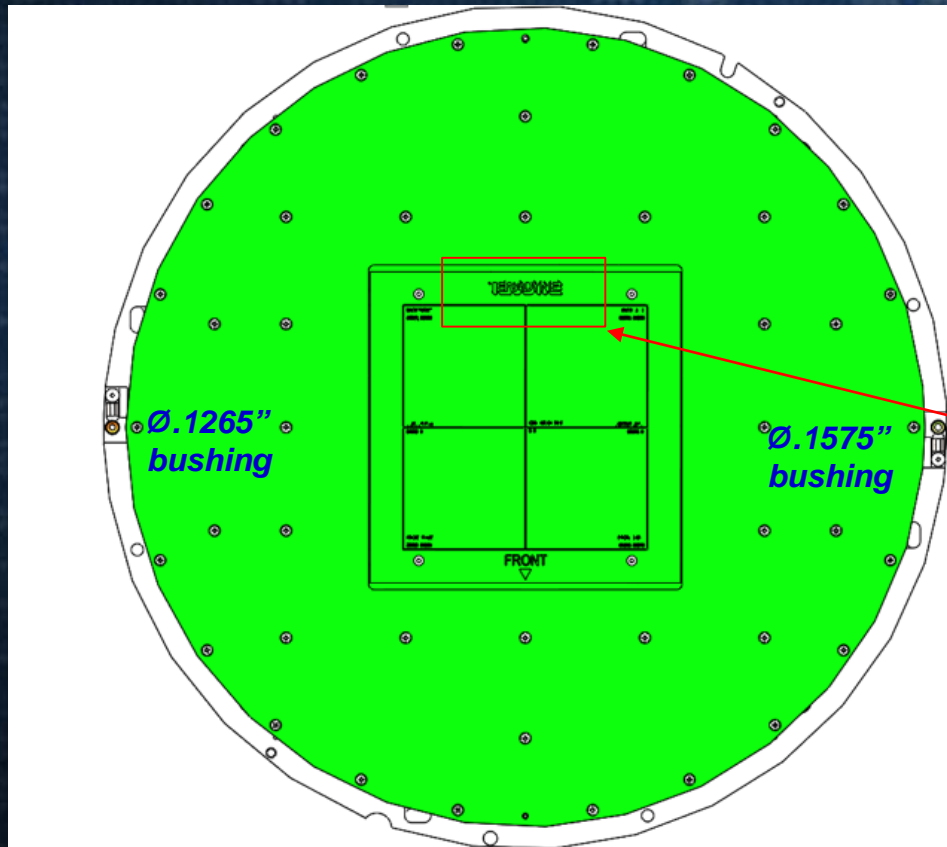
Teradyne Logo

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# J750-440J FLS Rotation Overview

0° POSITION

180° ROTATION



Teradyne  
logo

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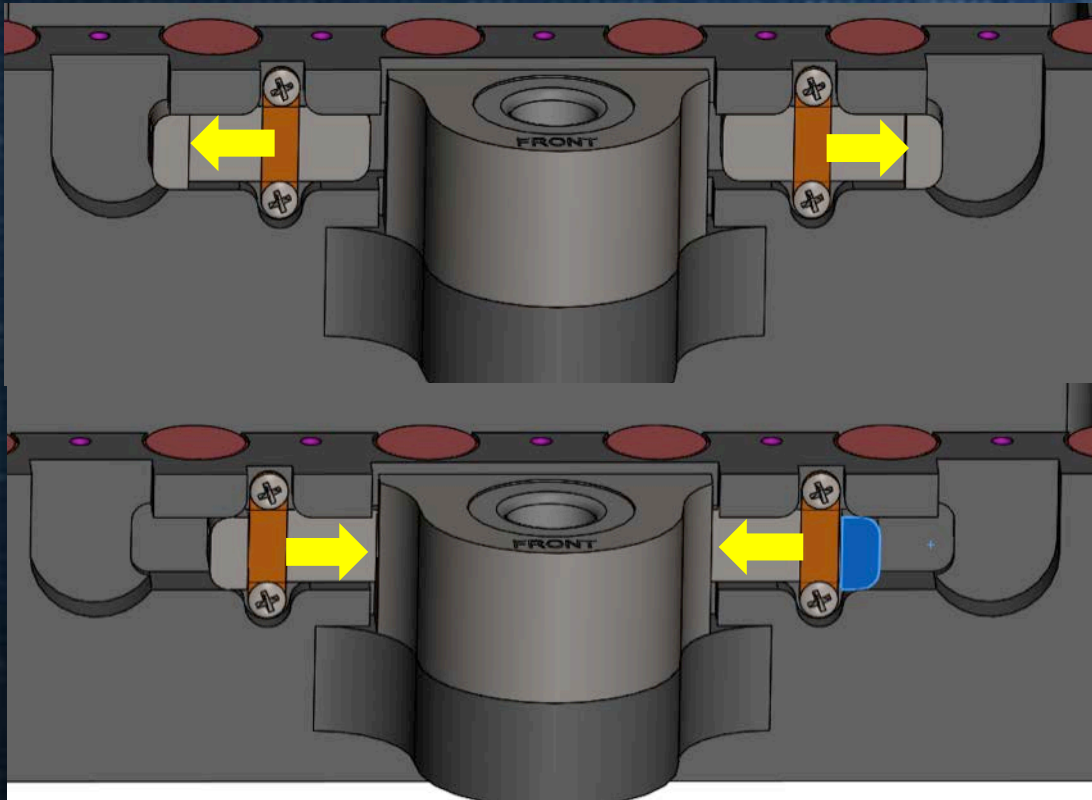


# FLS Bushing Exchange Feature

Tool-less design has dual purpose:

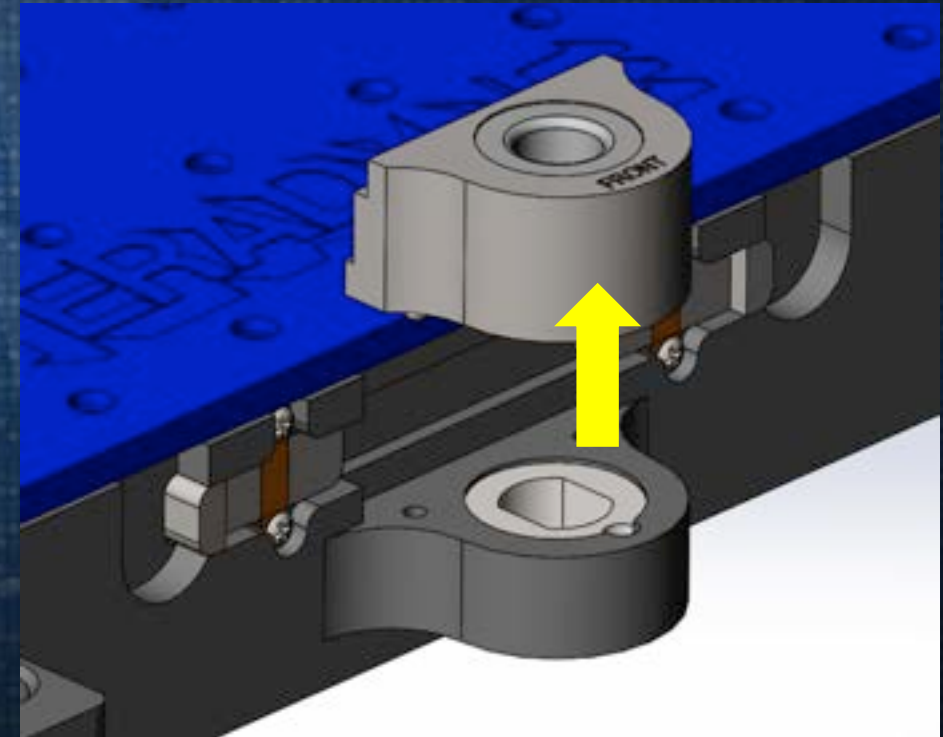
1. Enhance tool accuracy
2. Efficiency of rotation process

Bushing exchange  
allows for rotation  
on PC loader tray

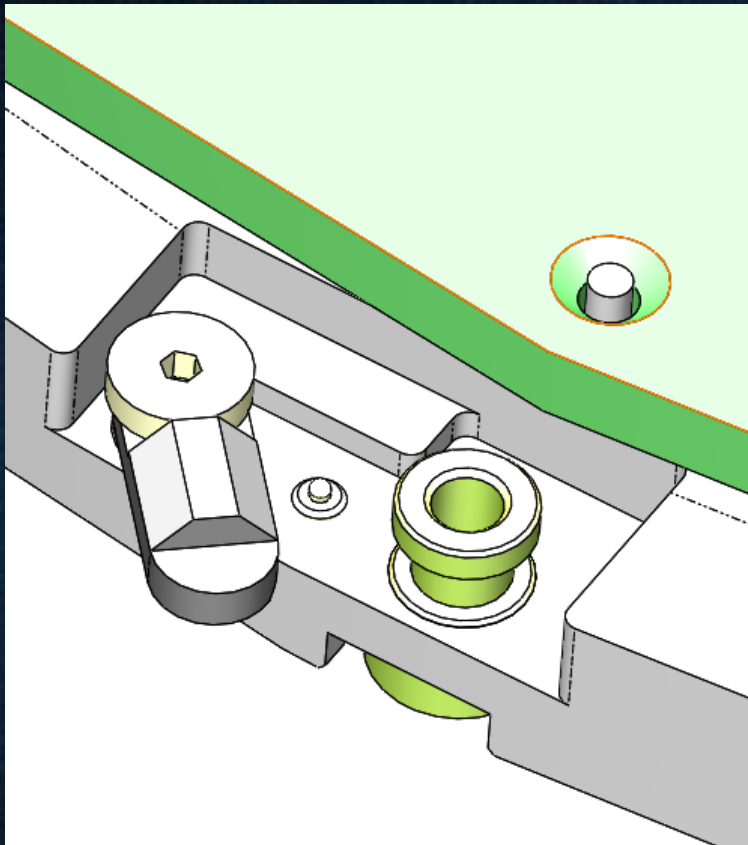


Open state

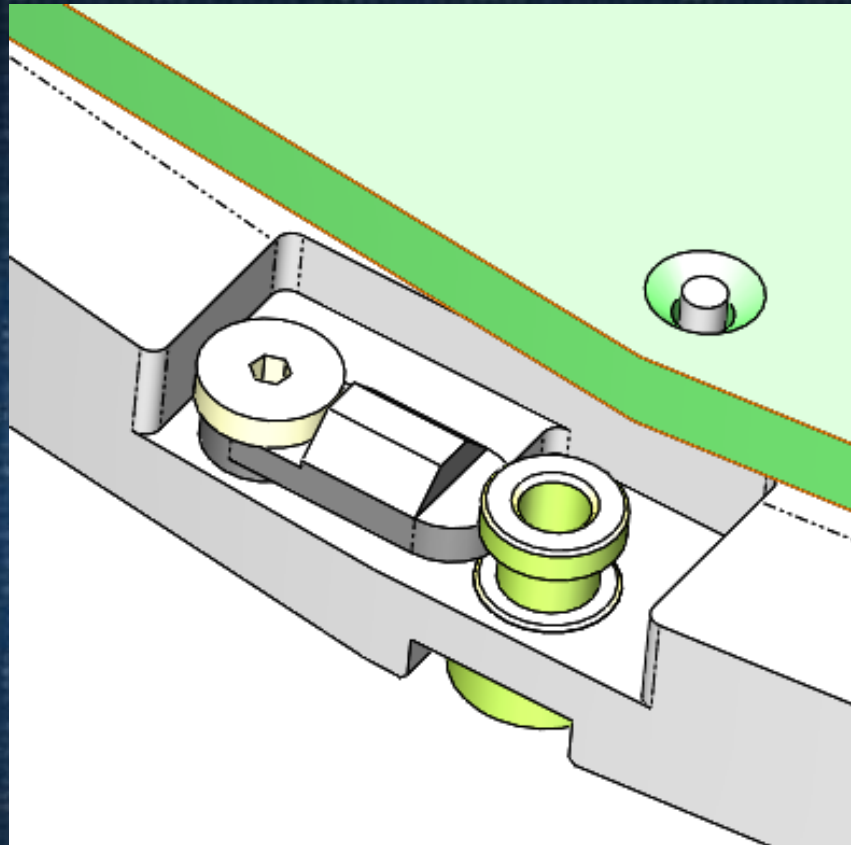
Latched state



# J750 Bushing Exchange

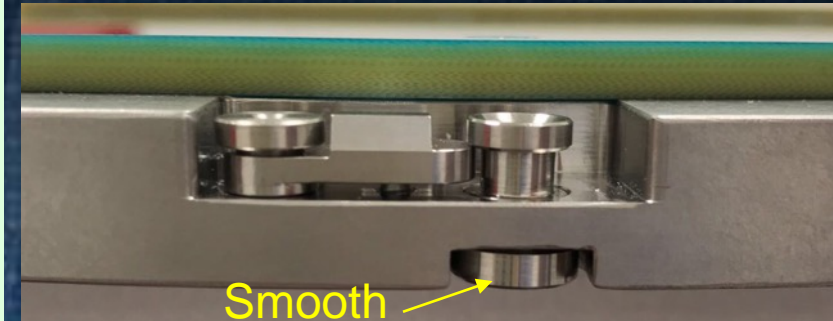


*Open state*



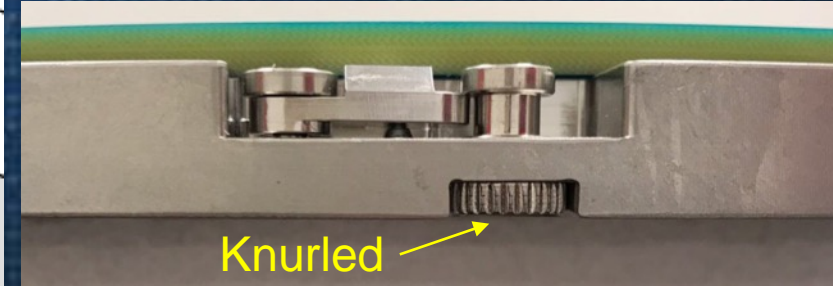
*Latched state*

0.1265" Bushing



Smooth

0.1575" Bushing

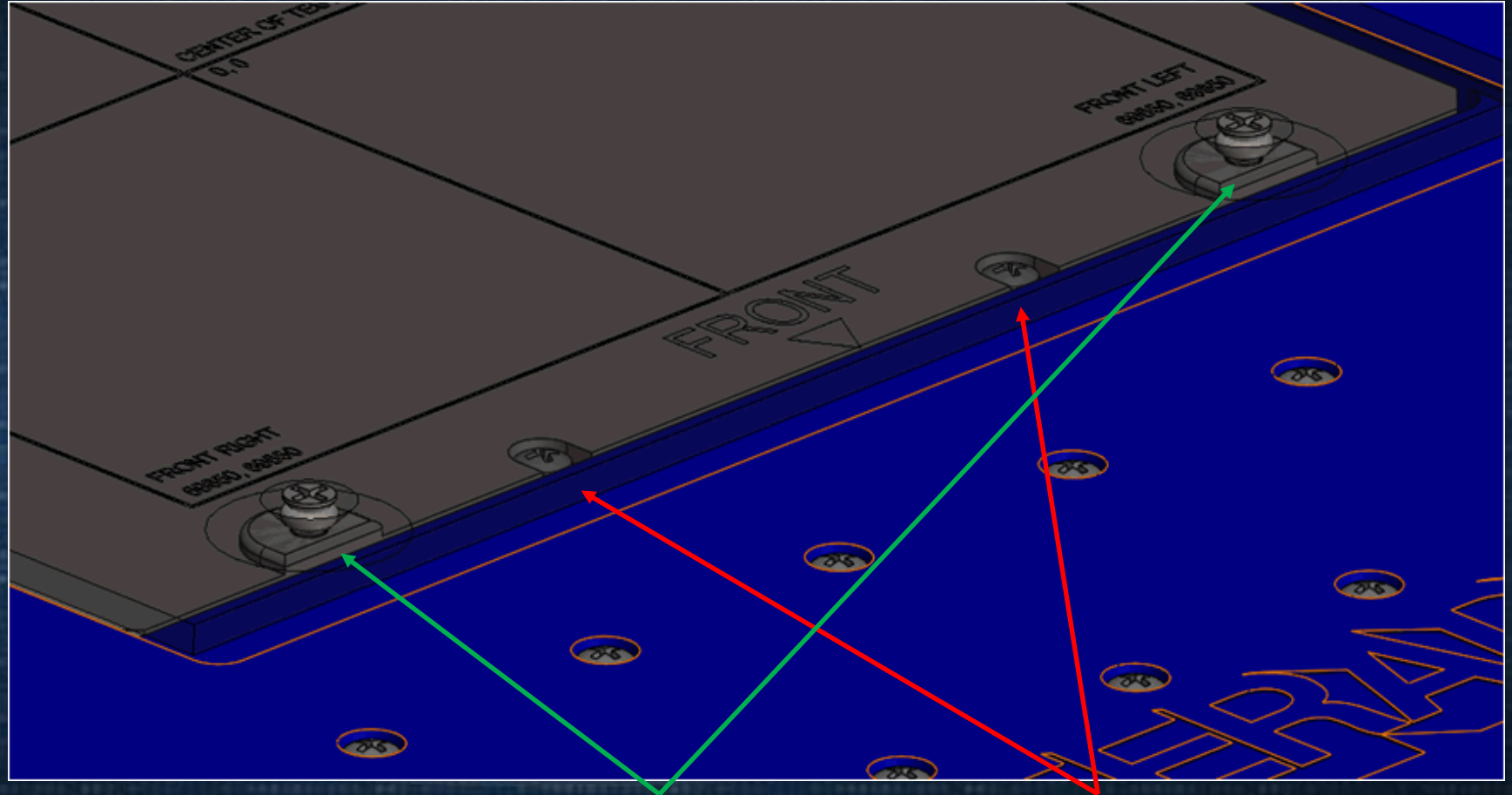


Knurled



# Emulates Probecard Architecture

- Rigidly attached structures
- Provides optimal PC correlation

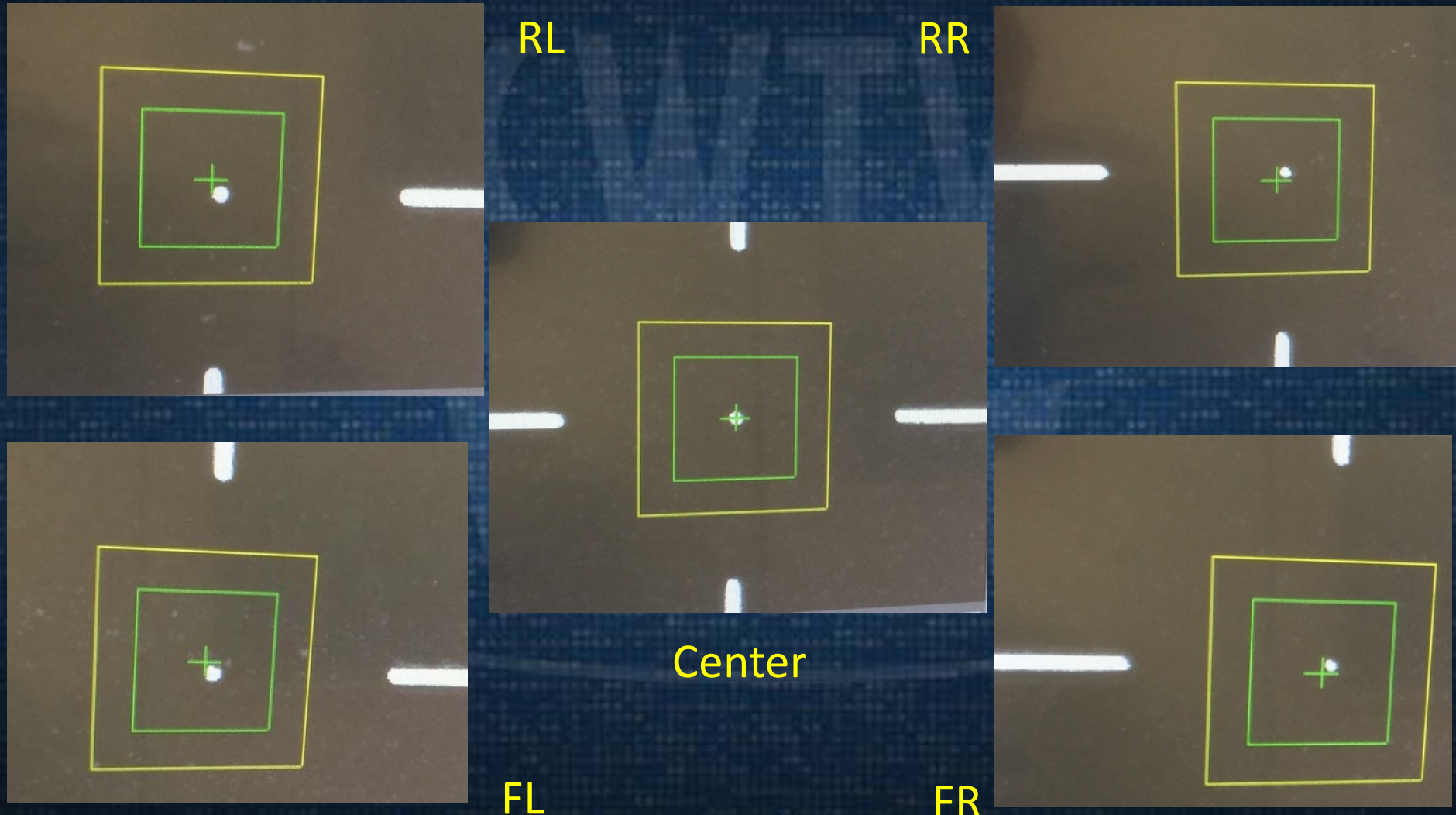


PCB targets mounted securely  
through Plate to PC stiffener

Plate mounted securely to  
PC stiffener under PCB

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# FLS Targets – Prober Macro View



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# FLS Calculator

Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	-3	
Rear Right	-19	
Front Right	17	
Front Left	5	

Input 4 Z-values from 0 degrees

Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	16	-1
Rear Right (0° Front Left)	5	0
Front Right (0° Rear Left)	-3	0
Front Left (0° Rear Right)	-18	1

Input 4 Z-values from 180 degrees

FLS Range	
2	

Adjust corner up or down

Head State Adjustments (reference)	
FLS Points	Move (um)
Rear Left	1
Rear Right	0
Front Right	0
Front Left	-1

Z-Movement Ref.	
Turn	Z (um)
"1/128"	5
"1/64"	9
"1/32"	18
"1/16"	36
"1/8"	73
"1/4"	145

Z guide

FLS Range	
2	

Co-planarity of test cell

Visual Reference	
Rear Left Target 1	Rear Right Target 2
-1	0
Front Left Target 4	Front Right Target 3
1	0

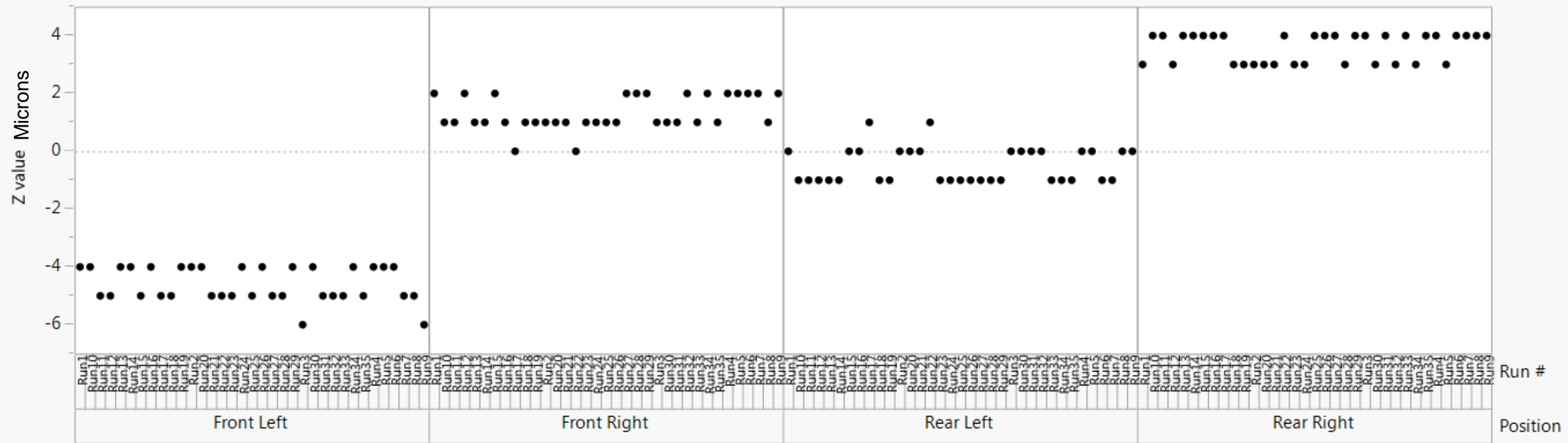
**Adjustment Instructions:**

1. Start with front corner largest value from zero. Try to achieve left /right symmetry.
2. Next, adjust both front corners equally to match rear.
3. Avoid adjusting rear (hinge area).
4. Only make small adjustment in rear for left / right symmetry.

**Tips**

Setting up device file, training targets or manual measurements:  
Always start in Rear Left location, continue clockwise.

# FLS Target Acquisition Repeatability

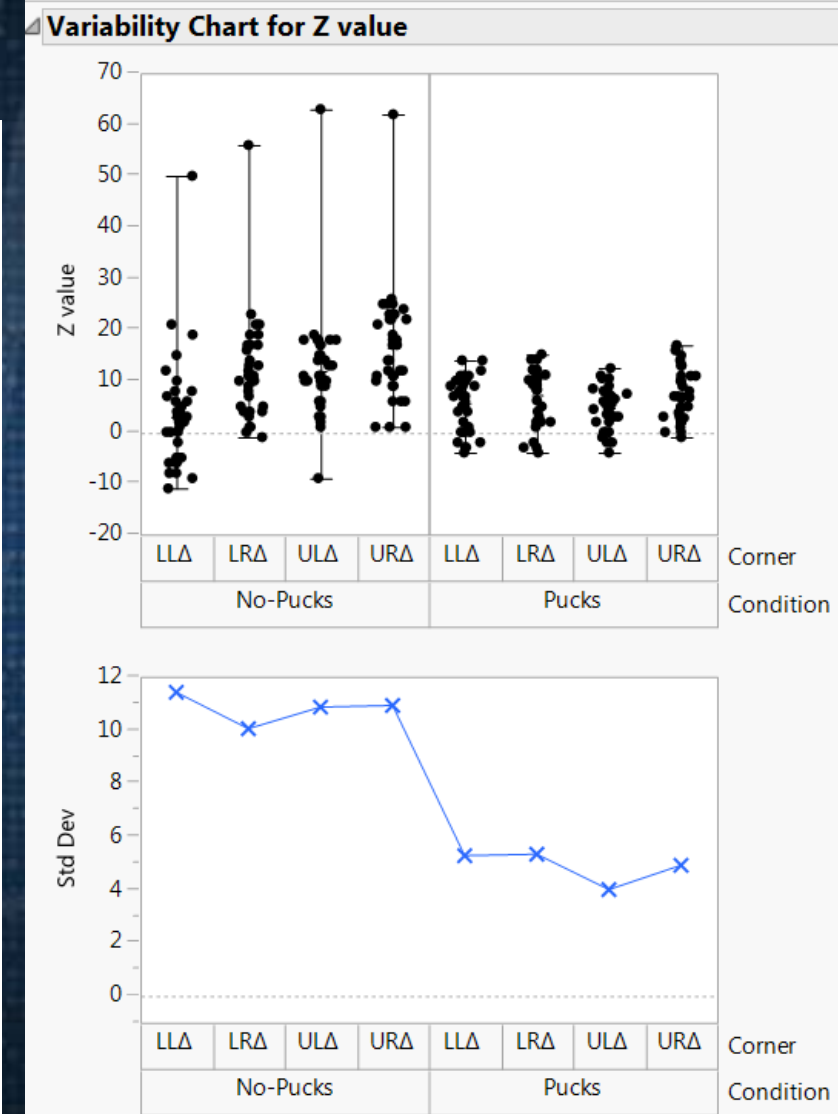
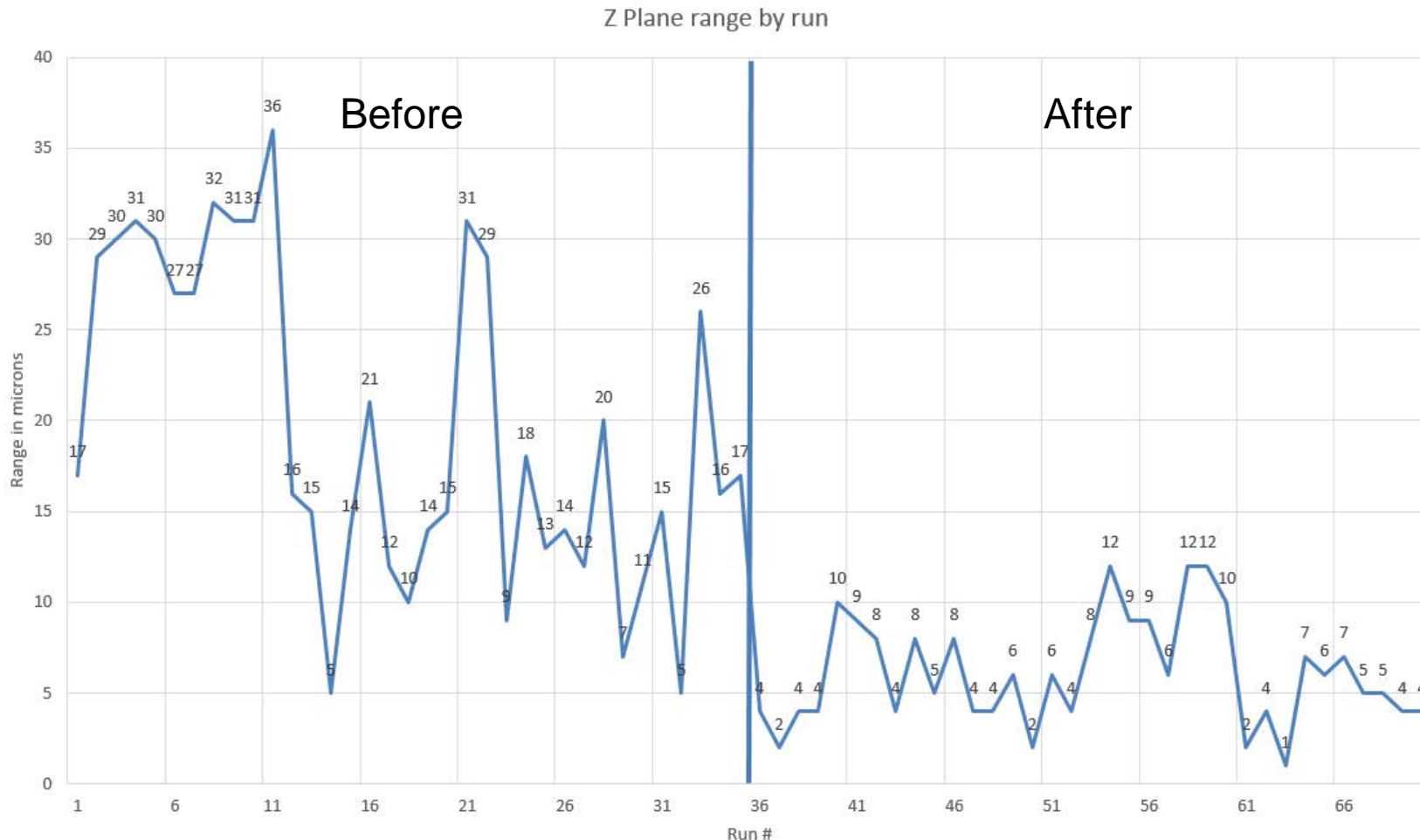




# UltraProbe Results

## Test Cell Docking

### Test Cell Co-Planarity



# J750 Results

Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	50	
Rear Right	-28	
Front Right	-39	
Front Left	17	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	66	105
Rear Right (0° Front Left)	-24	-41
Front Right (0° Rear Left)	-57	-107
Front Left (0° Rear Right)	14	42
FLS Range		
212		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	-73	
Rear Right	0	
Front Right	33	
Front Left	-42	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	
Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	31	
Rear Right	-16	
Front Right	-20	
Front Left	6	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	47	67
Rear Right (0° Front Left)	-18	-24
Front Right (0° Rear Left)	-38	-69
Front Left (0° Rear Right)	9	25
FLS Range		
136		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	-46	
Rear Right	0	
Front Right	23	
Front Left	-25	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	
Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	3	
Rear Right	-5	
Front Right	5	
Front Left	-3	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	25	20
Rear Right (0° Front Left)	4	7
Front Right (0° Rear Left)	-15	-18
Front Left (0° Rear Right)	-13	-8
FLS Range		
38		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	-7	
Rear Right	0	
Front Right	13	
Front Left	8	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	

FLS Range		
212		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
105		-41
Front Left Target 4		Front Right Target 3
42		-107

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
136		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
67		-24
Front Left Target 4		Front Right Target 3
25		-69

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
22		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
0		11
Front Left Target 4		Front Right Target 3
-11		-1

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
38		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
20		7
Front Left Target 4		Front Right Target 3
-8		-18

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
10		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
1		-4
Front Left Target 4		Front Right Target 3
6		-1

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	0	
Rear Right	-5	
Front Right	9	
Front Left	-4	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	25	16
Rear Right (0° Front Left)	3	7
Front Right (0° Rear Left)	-13	-13
Front Left (0° Rear Right)	-15	-10
FLS Range		
29		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	-5	
Rear Right	0	
Front Right	10	
Front Left	9	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	
Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	-5	
Rear Right	-4	
Front Right	16	
Front Left	-7	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	16	0
Rear Right (0° Front Left)	4	11
Front Right (0° Rear Left)	-6	-1
Front Left (0° Rear Right)	-15	-11
FLS Range		
22		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	0	
Rear Right	-6	
Front Right	1	
Front Left	6	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	
Enter FLS Data at 0°		
FLS Points	INPUT DATA (um)	
Rear Left	-3	
Rear Right	-12	
Front Right	14	
Front Left	0	
Enter FLS Data after Rotating 180°		
FLS Points	INPUT DATA (um)	Delta(um)
Rear Left (0° Front Right)	15	1
Rear Right (0° Front Left)	-4	-4
Front Right (0° Rear Left)	-4	-1
Front Left (0° Rear Right)	-6	6
FLS Range		
10		
Head State Adjustments (reference)		
FLS Points	Move (um)	
Rear Left	0	
Rear Right	3	
Front Right	1	
Front Left	-3	
Z-Movement Ref.		
Turn	Z (um)	
"1/128"	5	
"1/64"	9	
"1/32"	18	
"1/16"	36	
"1/8"	73	
"1/4"	145	
Upward (CW)	Upwards Towards Test head	
Downward (CCW)	Downward Into Prober	

FLS Range		
29		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
16		7
Front Left Target 4		Front Right Target 3
-10		-13

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
22		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
0		11
Front Left Target 4		Front Right Target 3
-11		-1

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		

FLS Range		
10		
Visual Reference		
Rear Left Target 1		Rear Right Target 2
1		-4
Front Left Target 4		Front Right Target 3
6		-1

Adjustment Instructions:		
1. Start with front corner largest value from zero. Try to achieve left /right symmetry. 2. Next, adjust both front corners equally to match rear. 3. Avoid adjusting rear (hinge area). 4. Only make small adjustment in rear for left / right symmetry.		



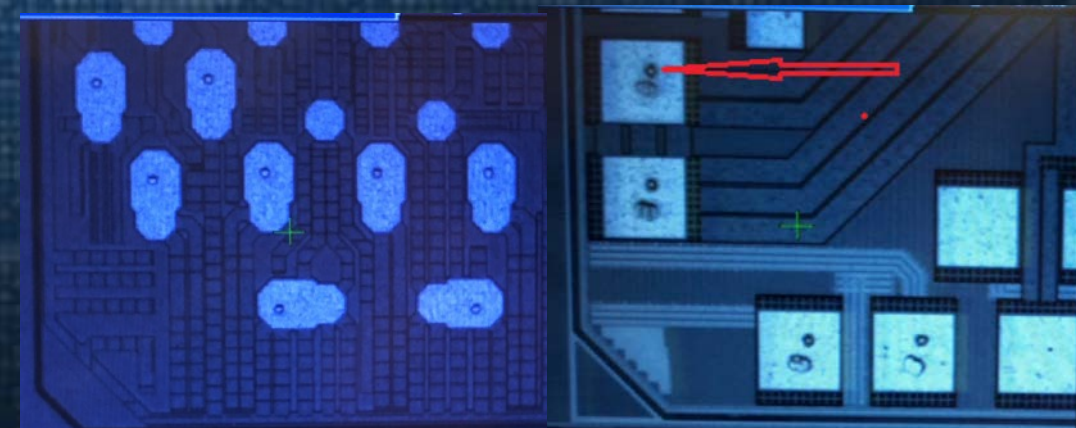
# J750 Probecard Correlation Results

- New PC design – array (~4" x 4")
- Four corner probes of array were within 13 microns
  - (-2, 0, -5, 8).
- PC metrology 50 microns planarity
- PC electrical continuity check on prober w/tester was 45 microns
- Uniform probe marks on all pads

Prober optical results

Probe Alignment Results						
Probe Center	X/	Y/	Z	Coordinate		
	[ 150689/	341107/	47196]	μm		OK
Probe Angle	θ	Coordinate				
	[ -974]	x0.0001°				
Pin Z Coordinate	Pin1/	Pin2/	Pin3/	Pin4	ZCoordinate	
	[ -2/	0/	-5/	8]	μm	
Probe Settings	Size	X/	Y/	Z	Position	
Pin 1	[ 0]	μm	[ 171793/	365633/	46970]	μm
Pin 2	[ 0]	μm	[ 127879/	366182/	46965]	μm
Pin 3	[ 0]	μm	[ 128052/	318113/	46965]	μm
Pin 4	[ 0]	μm	[ 171830/	318170/	46977]	μm
Illumination	Mode/	Value				
	[ 4/	55]				

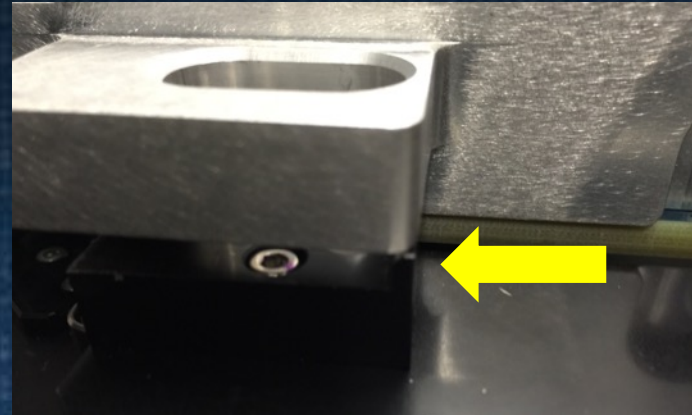
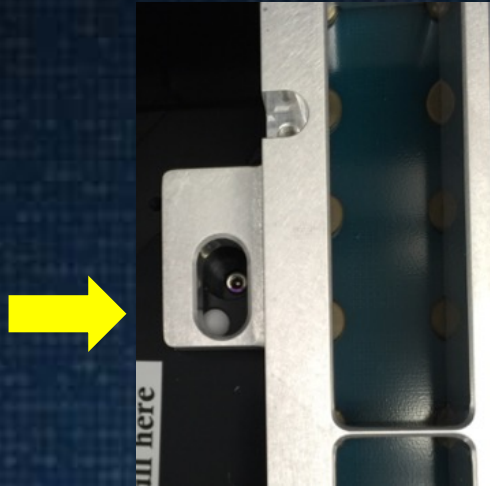
Probe marks





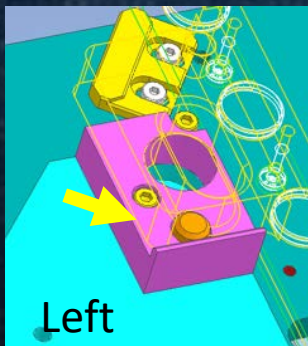
# Accretech kit for UltraProbe – PC Tray

Before

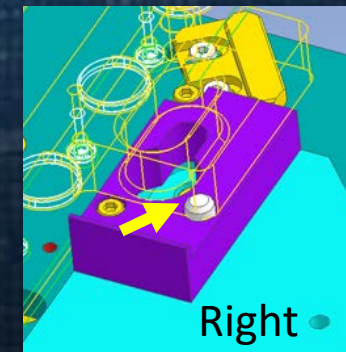
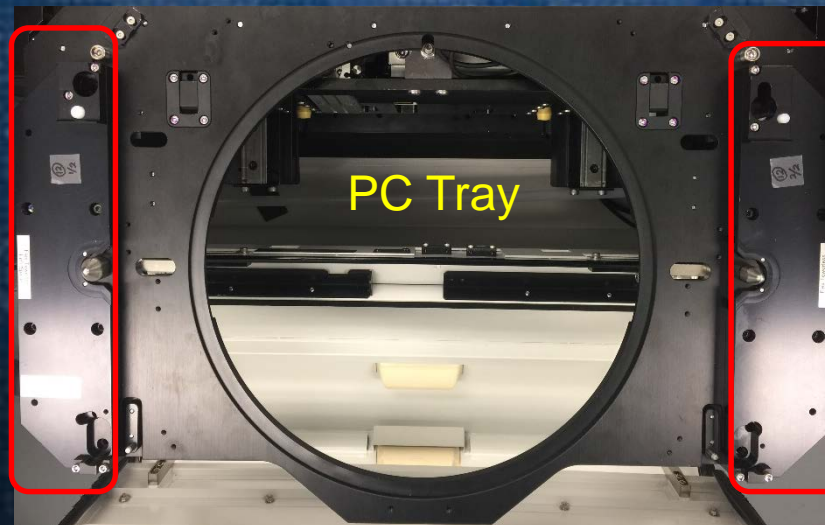


P/N: 1C0000231131-003  
Kit supplied by Accretech

After



Tab block is elongated  
Sensor Pin re-positioned



SW Test Workshop | June 3-6, 2018 Sensor Pin is re-positioned



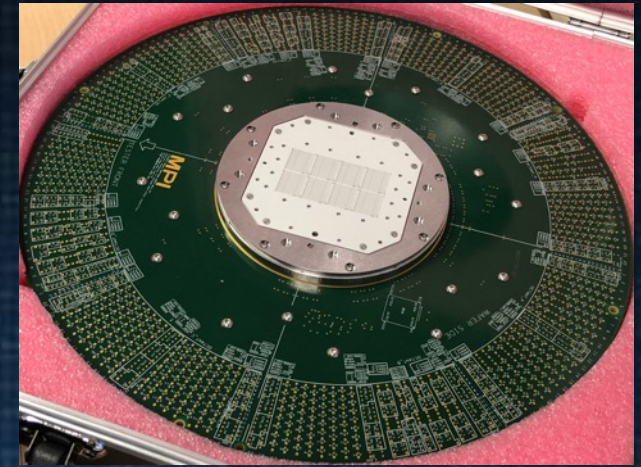
# Conclusions

- ✓ • Repeatable docking for UltraProbe
- ✓ • Efficient PLP field conversion capability
- ✓ • Maintain knowledge & experience of proven tools
- ✓ • Emulate a probecard architectures for accuracy
- ✓ • Compatible on multiple tester platforms
- ✓ • Eliminated tool calibrations
- ✓ • Achieve a test cell co-planarity of <20 microns (5.5" x 5.5")
- 😊 • Compatibility on probers – PC tray conversion



# Future Work

- **FLS for J750 with 300mm towers**
  - Probe array sizes are increasing
- **FLS for ETS-800 test cells**
- **Implement Auto-leveling / Auto-tilt feature of prober with FLS**
  - Automated head plate adjustment by stepper motors
    - Operator enables feature, only loads / unloads FLS both rotations
    - Prober does all calculations, adjusts, disables feature
  - A “one and done” process for setup or verification

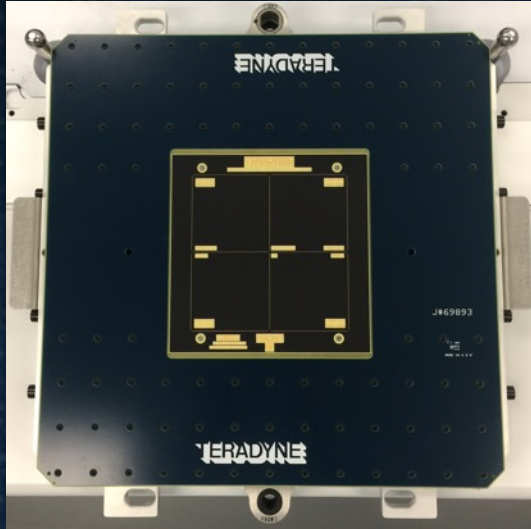


~18,000 probes



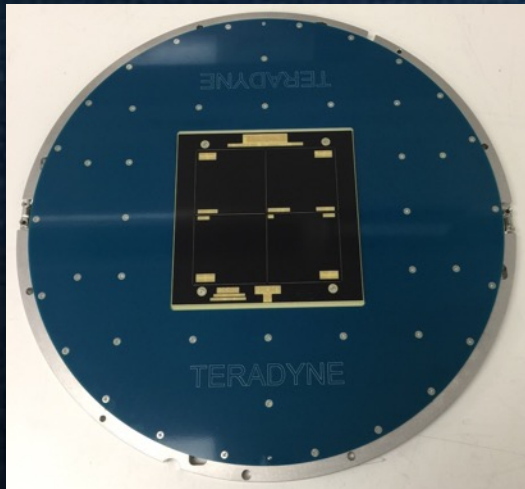
# Contributor Appreciation

Doug Garrett - NXP



SECURE CONNECTIONS  
FOR A SMARTER WORLD

Hoang Nguyen - Microsemi



**Microsemi**

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